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Form PTD 1449 (Modified)	ICT O	1 2003 PATENT AND TRA	NT OF COMMERCE ADEMARK OFFICE	ATTY DOCKET NO. 0557-4969-2		SERIAL NO. 09/552,657		
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LIST	REFE	RENCES CITED BY A	PPLICANT	Tomohiro NAKAJIMA				
LIST OF REFERENCES CITED BY APPLICANT				RCE FILED		GROUP		
				July 25, 2002		2872		
				U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
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		DOCUMENT NUMBER	DATE	COUNTRY		l	TRANSLATION YES NO	
1.1-	AO	11-023988	01-29-99	Japan (with English Abstract)			×	
1.6	AP	10-090616	04-10-98	Japan (with English Abstract)			x	
1.1	AQ	10-213773	08-11-98	Japan (with English Abstract)			x	
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		OTHER R	EFERENCES (	Including Author, Title, Date, Pertiner	nt Pages, ef	tc.)		
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Examiner		James	s Pha	m	Date Con	Date Considered 12/03		
*Examiner: Iniconformance	itial if ro	eference is considered,	, whether or not	t citation is in conformance with MPEP 6 with next communication to applicant.	509; Draw lir	ne through	citation if not in	

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